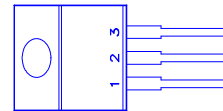
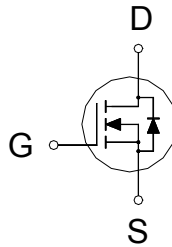




PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
60V	30m Ω	34A



1. GATE
2. DRAIN
3. SOURCE

ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ }^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current	$T_C = 25\text{ }^\circ\text{C}$	I_D	34	A
	$T_C = 100\text{ }^\circ\text{C}$		21	
Pulsed Drain Current ¹		I_{DM}	110	
Avalanche Current		I_{AS}	29	
Avalanche Energy	$L = 0.1\text{mH}$	E_{AS}	41	mJ
Power Dissipation	$T_C = 25\text{ }^\circ\text{C}$	P_D	58	W
	$T_C = 100\text{ }^\circ\text{C}$		23	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	$^\circ\text{C}$

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	$R_{\theta JC}$		2.15	$^\circ\text{C} / \text{W}$
Junction-to-Ambient	$R_{\theta JA}$		62.5	

¹Pulse width limited by maximum junction temperature.

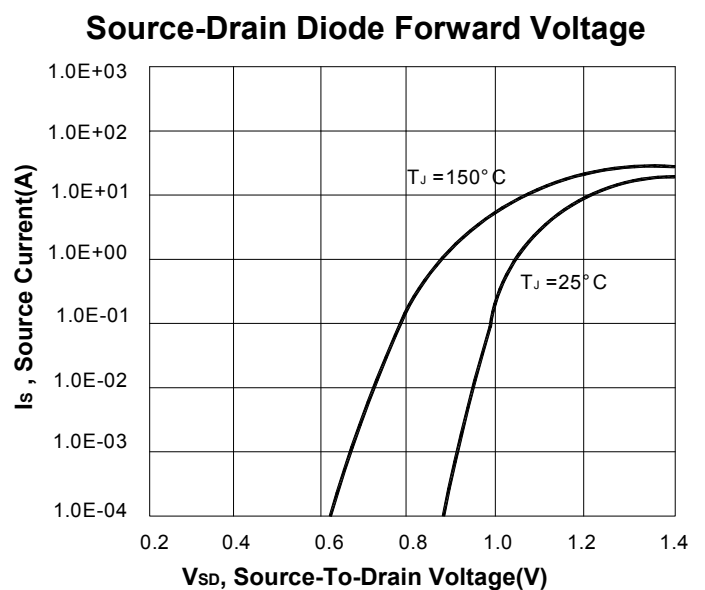
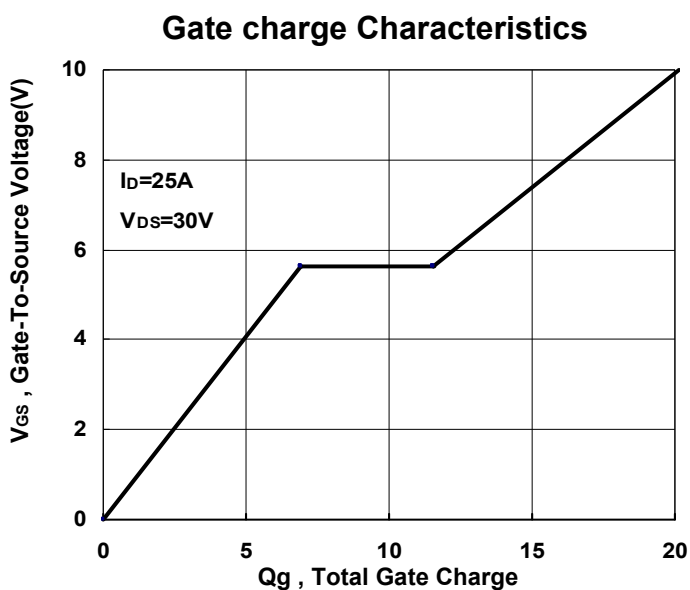
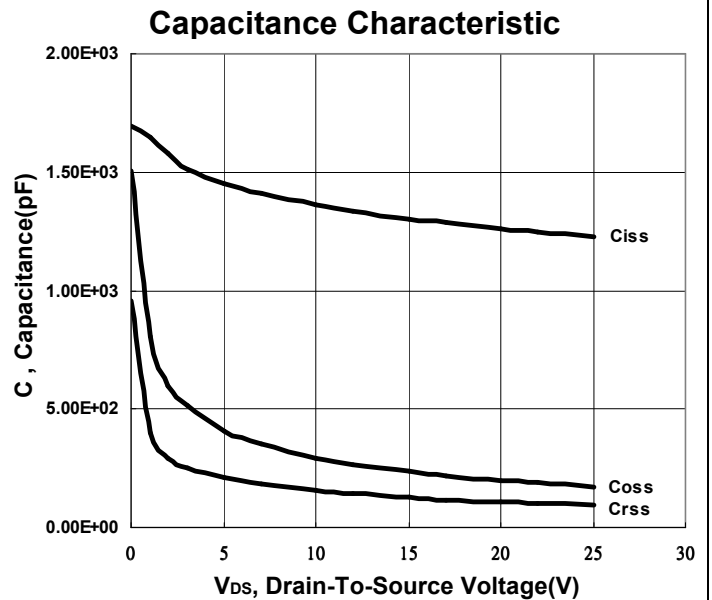
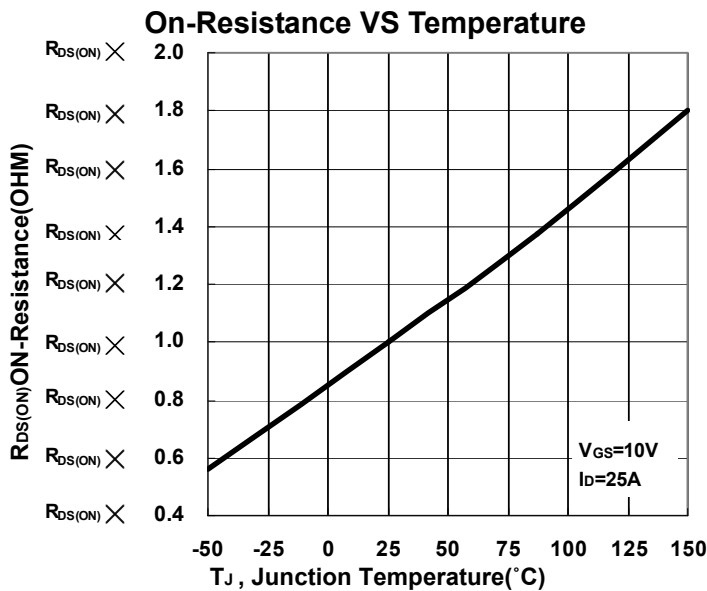
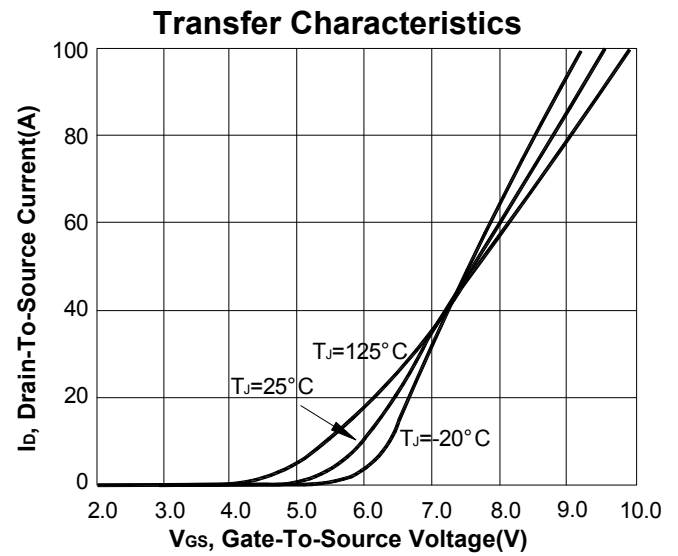
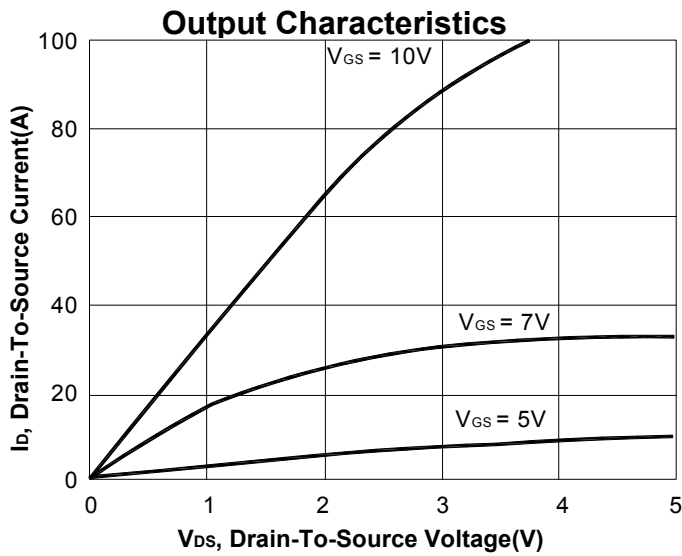
ELECTRICAL CHARACTERISTICS ($T_J = 25\text{ }^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	60			V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	1.8	2.4	4	
Gate-Body Leakage	I _{GSS}	V _{DS} = 0V, V _{GS} = ±20V			±250	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48V, V _{GS} = 0V			1	μA
		V _{DS} = 40V, V _{GS} = 0V, T _J = 125 °C			10	
On-State Drain Current ¹	I _{D(ON)}	V _{DS} = 5V, V _{GS} = 10V	110			A
Drain-Source On-State Resistance ¹	R _{DS(ON)}	V _{GS} = 10V, I _D = 25A		26	30	mΩ
Forward Transconductance ¹	g _{fs}	V _{DS} = 5V, I _D = 25A		25		S

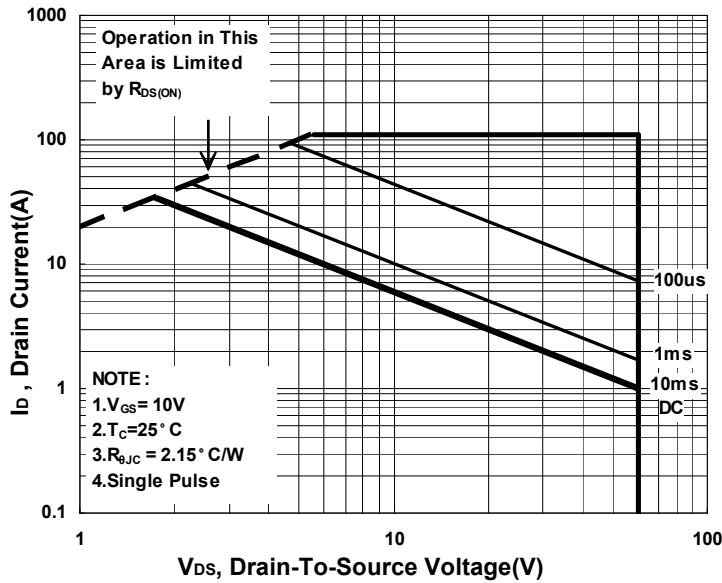
DYNAMIC						
Input Capacitance	C _{iss}	V _{GS} = 0V, V _{DS} = 25V, f = 1MHz		1240		pF
Output Capacitance	C _{oss}			173		
Reverse Transfer Capacitance	C _{rss}			97		
Gate Resistance	R _g	V _{GS} = 0V, V _{DS} = 0V, f = 1MHz		1.7		Ω
Total Gate Charge ²	Q _g	V _{DS} =30V, V _{GS} = 10V, I _D = 25A		21		nC
Gate-Source Charge ²	Q _{gs}			7		
Gate-Drain Charge ²	Q _{gd}			5		
Turn-On Delay Time ²	t _{d(on)}	V _{DS} = 0.5V _{(BR)DSS} , R _L = 1.5Ω I _D ≅ 20A, V _{GS} = 10V, R _G = 5.6 Ω		10		nS
Rise Time ²	t _r			145		
Turn-Off Delay Time ²	t _{d(off)}			28		
Fall Time ²	t _f			77		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T _J = 25 °C)						
Continuous Current	I _S				34	A
Forward Voltage ¹	V _{SD}	I _F = 25A, V _{GS} = 0V			1.3	V
Reverse Recovery Time	t _{rr}	I _F = I _S , dI _F /dt = 100A / μS		40		nS
Reverse Recovery Charge	Q _{rr}			48		nC

¹Pulse test : Pulse Width $\leq 300 \mu sec$, Duty Cycle $\leq 2\%$.

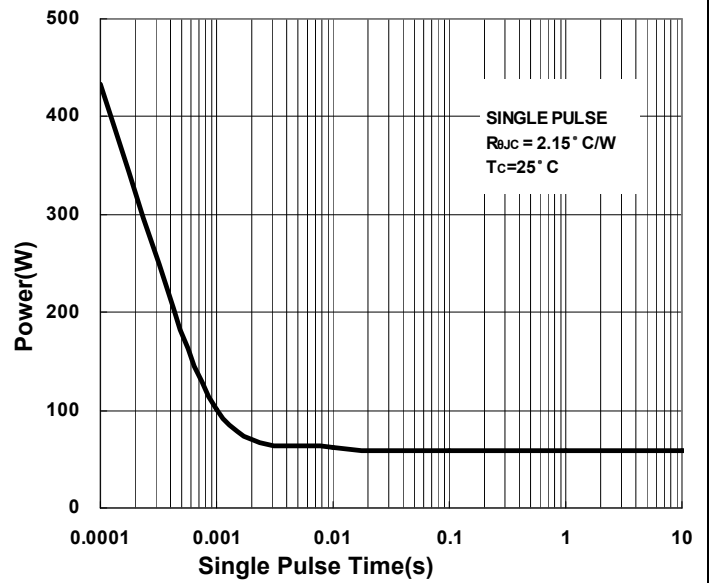
²Independent of operating temperature.



Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

